

AI based inspection system for cabling anomaly detection

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The problem



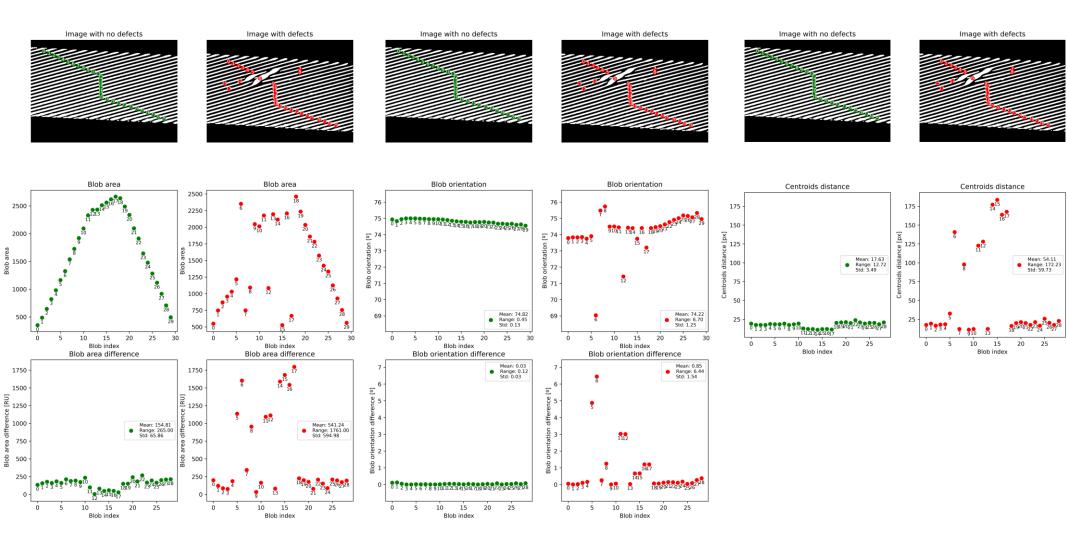


Reduced unhealthy images dataset

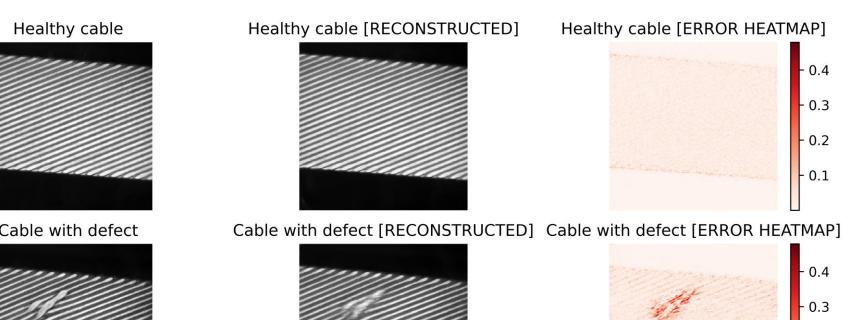
Huge healthy images dataset

Repetitive pattern/features over timer







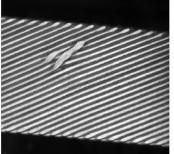


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- 0.2

- 0.1

Cable with defect





Feature statistical analysis	Autoencoders
+ Real-world data calibration	- Sensitive to setup changes
+ Allows parametrization and algorithm control	- "Blackbox"
+ Easy to modify the algorithm	- Training time can be a handicap for development
- Can be slow	+ Very fast
- Software complexity	+ Easy to integrate in existing software

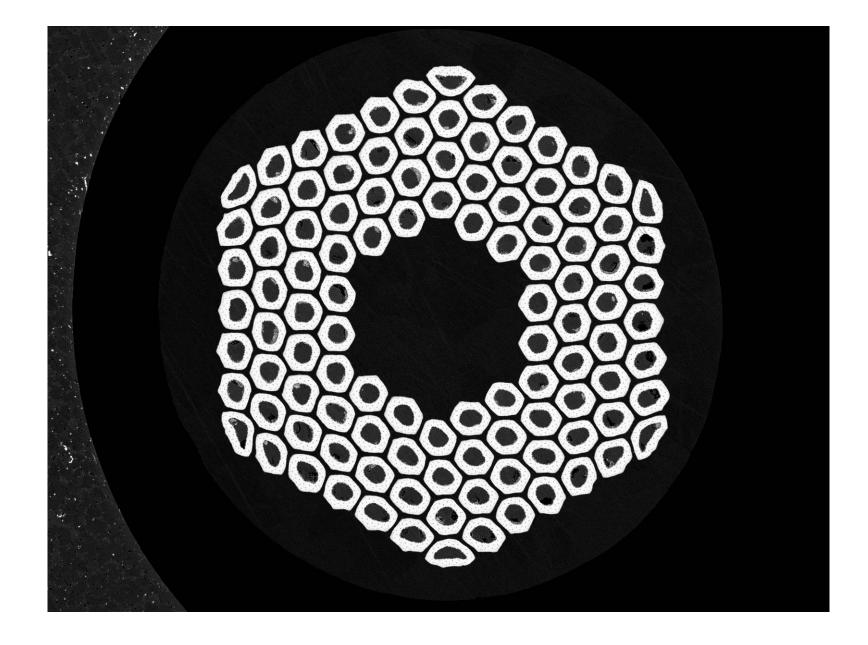


Extracting the geometry of Nb₃Sn wires for Quench simulations using AI

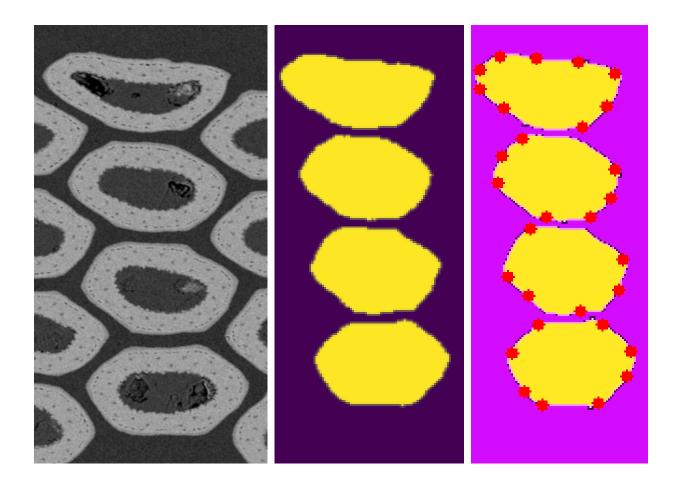
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The problem





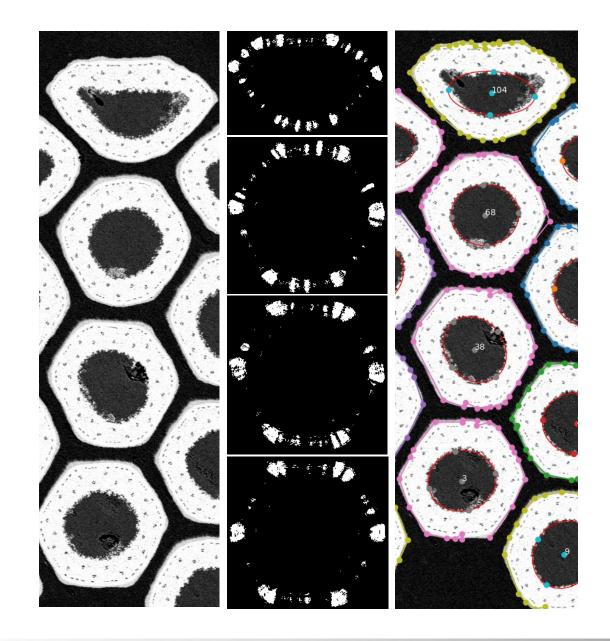




Jianbo Shi and Carlo Tomasi. Good features to track. In Computer Vision and Pattern Recognition, 1994. Proceedings Cordama, Josef Baumann 1994 IEEE Computer Society Conference on, pages 593–600. IEEE, 1994.

Second approach: Machine learning





Arganda-Carreras, I., Kaynig, V., Rueden, C., Eliceiri, K. W., Schindelin, J., Cardona, A., & Sebastian Seung, H. (2017). Trainable Weka Segmentation: a machine learning tool for microscopy pixel classification. *Bioinformatics*, 33(15), 24/24-24/26: manes Cardama, Josef Baumann



Harris (mathematical)	Weka (AI)
+ well known algorithm	- "black box"
+ low computational requirements (faster)	 high computational requirement (slower)
+ no training needed	- needs to be trained
 sensitive to scale and rotation 	+ adaptable
- careful parameter tuning needed	- overfitting
 Not robust to noise and low contrast areas 	+ more flexible